Search Notes



Application/Control No.

10530740

Applicant(s)/Patent Under Reexamination

AHRNDT, THOMAS

Examiner

Art Unit 2446

SHAQ TAHA

SEARCHED

Class	Subclass	Date	Examiner
709	224	08/27/2008	S. Taha
709	224	01/23/2009	S. Taha
709	224	05//29/2009	S. Taha
709	224	12/22/2009	S. Taha
709	204	08/24/2010	S. Taha

SEARCH NOTES

Search Notes	Date	Examiner
EAST (USPAT, US-PGPUB, EPO, JPO, DERWENT, IBM_TDB), see	08/27/2008	S. Taha
attached; NPL: IEEE; Inventor Search/DP; Text search in cls		
709/223,225,229.		
EAST (USPAT, US-PGPUB, EPO, JPO, DERWENT, IBM_TDB), see	01/23/2009	S. Taha
attached; NPL: IEEE; Inventor Search/DP; Text search in cls		
709/223,225,229.		
EAST (USPAT, US-PGPUB, EPO, JPO, DERWENT, IBM_TDB), see	05/29/2009	S. Taha
attached; NPL: IEEE; Inventor Search/DP; Text search in cls		
709/223,225,229.		
EAST (USPAT, US-PGPUB, EPO, JPO, DERWENT, IBM_TDB), see	12/22/2009	S. Taha
attached; NPL: IEEE; Inventor Search/DP; Text search in cls		
709/223,225,229.		
EAST (USPAT, US-PGPUB, EPO, JPO, DERWENT, IBM_TDB), see	08/24/2010	S. Taha
attached; NPL: IEEE; Inventor Search/DP; Text search in cls		
709/223,225,229.		

INTERFERENCE SEARCH

- 1				
	Class	Subclass	Date	Examiner